## Search Notes



Application/Control No.	

10576169

Applicant(s)/Patent Under Reexamination OGASAWARA ET AL.

Art Unit

Examiner
Tianjie Chen

2627

## SEARCHED

CLANONED				
Class	Subclass	Date	Examiner	
720	624			
	651			
	646			
	647			
369	263	6/16/2008	TJ	

## SEARCH NOTES

Search Notes	Date	Examiner
East Reports	6/16/2008	TJ

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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